

■ PRODUCT CHARACTERISTICS

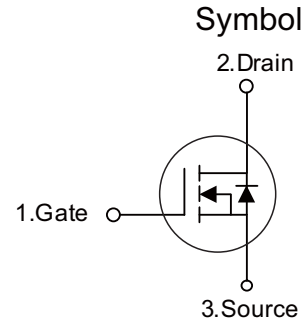
VDSS	600V
$R_{DS(on)}$ Typ(@V _{GS} =10 V)	0.62Ω
Qg@type	35.7nC
ID	15A

■ APPLICATIONS

- * High efficiency switch mode power supplies
- * Electronic lamp ballasts based on half bridge
- * LED power supplies

■ FEATURES

- * Fast switching capability
- * Avalanche energy specified
- * Improved dv/dt capability, high ruggedness



■ ORDER INFORMATION

Order codes		Package	Packing
Halogen-Free	Halogen		
N/A	MOT15N60F	TO-220F	50 pieces/Tube
N/A	MOT15N60A	TO-220	50 pieces/Tube

■ ABSOLUTE MAXIMUM RATINGS (T_C = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain to Source Voltage		V _{DSS}	600	V
Gate to Source Voltage		V _{GSS}	±30	V
Continuous Drain Current	Continuous	I _D	15	A
	Pulsed (Note 2)	I _{DM}	60	A
Avalanche Current (Note 2)		I _{AR}	6.4	A
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	205	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	2.45	V/ns
Power Dissipation	TO-220	P _D	250	W
	TO-220F		54	W
Junction Temperature		T _J	+150	°C
Storage Temperature		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating : Pulse width limited by maximum junction temperature.

3. L=10mH, I_{AS}=6.4A, V_{DD}= 50V, R_G=25Ω, Starting T_J=25°C

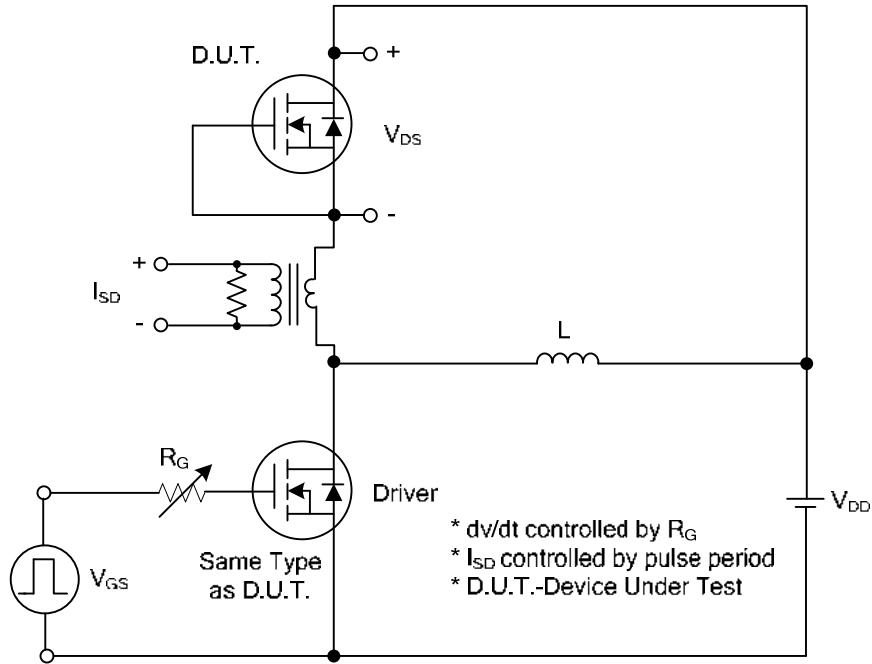
4. I_{SD} ≤15A, di/dt ≤200A/μs, V_{DD} ≤BV_{DSS}, Starting T_J=25°C

■ ELECTRICAL CHARACTERISTICS ($T_c=25^\circ\text{C}$, unless otherwise noted)

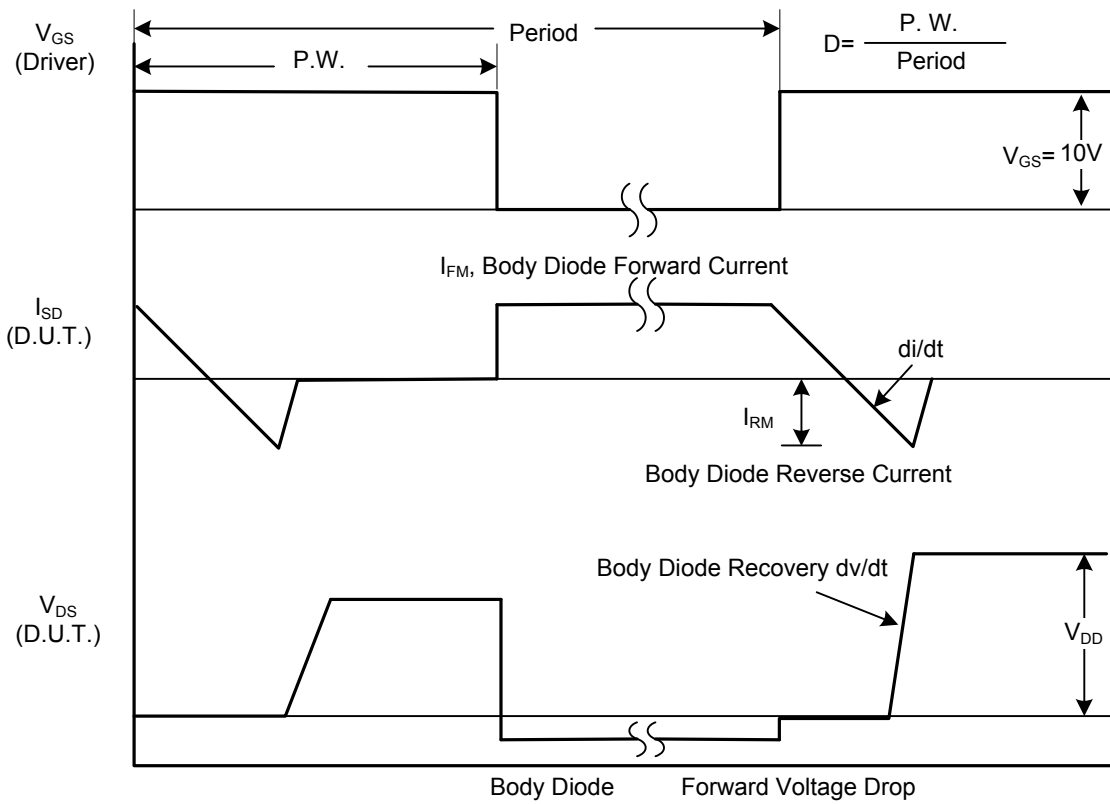
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Off characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	600	-	-	V
Drain-Source Leakage Current	I_{DSS}	$V_{DS}=600V, V_{GS}=0V$	-	-	1	μA
Gate- Source Leakage Current	Forward	$V_{GS}=+30V, V_{DS}=0V$	-	-	+100	nA
	Reverse	$V_{GS}=-30V, V_{DS}=0V$	-	-	-100	nA
On characteristics						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	2.0	-	4.0	V
Drain-Source On-State Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=7.5A$	-	0.62	0.65	Ω
Dynamic characteristics						
Input Capacitance	C_{ISS}	$V_{DS}=25V, V_{GS}=0V, f=1.0\text{MHz}$	-	2600	-	pF
Output Capacitance	C_{OSS}		-	260	-	pF
Reverse Transfer Capacitance	C_{RSS}		-	22	-	pF
Switching characteristics						
Total Gate Charge (Note 1)	Q_G	$V_{DS}=480V, V_{GS}=10V, I_D=15A,$ $I_G = 100\mu A$ (Note 1, 2)	-	35.7	-	nC
Gate-Source Charge	Q_{GS}		-	12.4	-	nC
Gate-Drain Charge	Q_{GD}		-	12.8	-	nC
Turn-ON Delay Time (Note 1)	$t_{D(ON)}$	$V_{DD}=30V, V_{GS}=10V, I_D=0.5A,$ $R_G=25\Omega$ (Note 1, 2)	-	105	-	ns
Turn-ON Rise Time	t_R		-	115	-	ns
Turn-OFF Delay Time	$t_{D(OFF)}$		-	600	-	ns
Turn-OFF Fall Time	t_F		-	120	-	ns
Source-drain diode ratings and characteristics						
Maximum Body-Diode Continuous Current	I_S		-	-	15	A
Maximum Body-Diode Pulsed Current (Note 1)	I_{SM}		-	-	60	A
Drain-Source Diode Forward Voltage (Note 1)	V_{SD}	$I_S=15A, V_{GS}=0V$	-	-	1.4	V
Body Diode Reverse Recovery Time	t_{rr}	$I_S=15A, V_{GS}=0V,$	-	510	-	ns
Body Diode Reverse Recovery Charge	Q_{rr}	$dI_F/dt=100A/\mu s$ (Note 1)	-	8.2	-	μC

Notes: 1. Pulse Test : Pulse width $\leq 300\mu s$, Duty cycle $\leq 2\%$.
 2. Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS

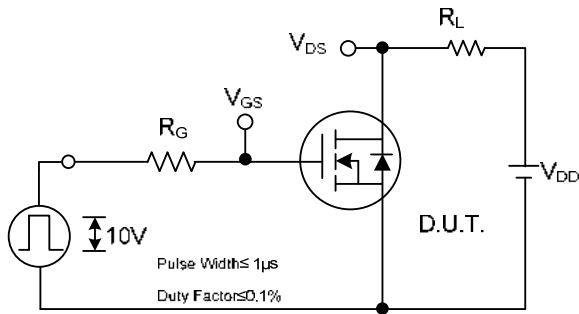


Peak Diode Recovery dv/dt Test Circuit

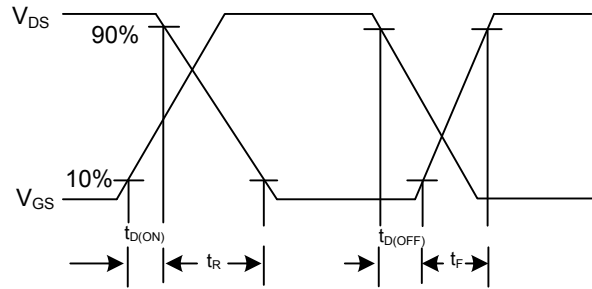


Peak Diode Recovery dv/dt Waveforms

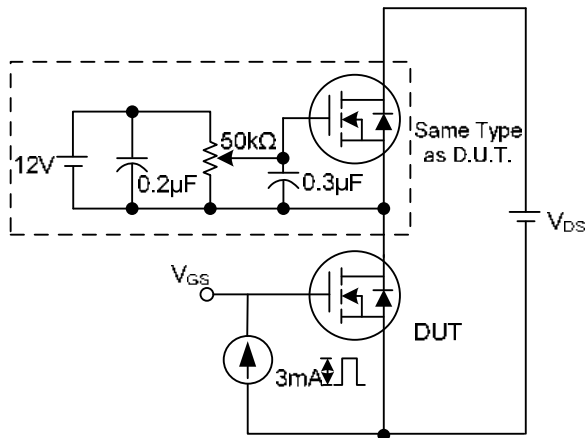
■ TEST CIRCUITS AND WAVEFORMS(Cont.)



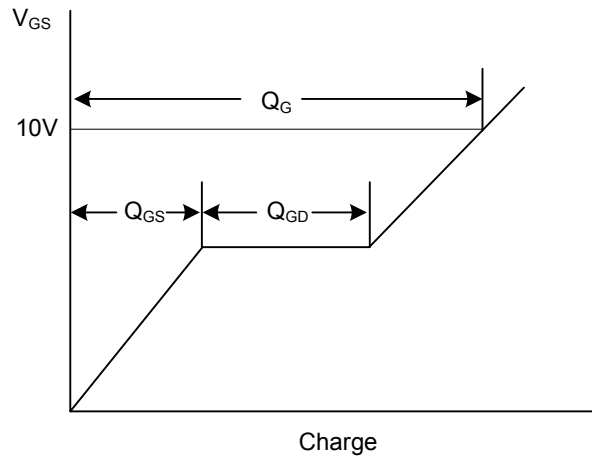
Switching Test Circuit



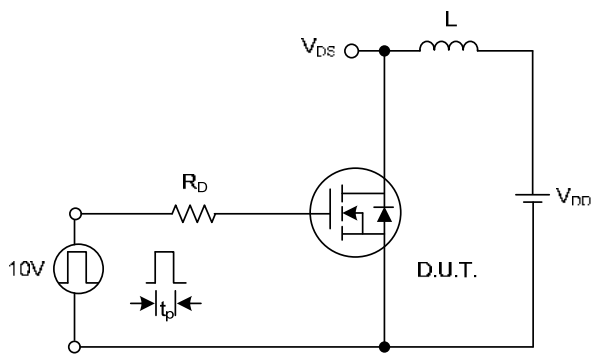
Switching Waveforms



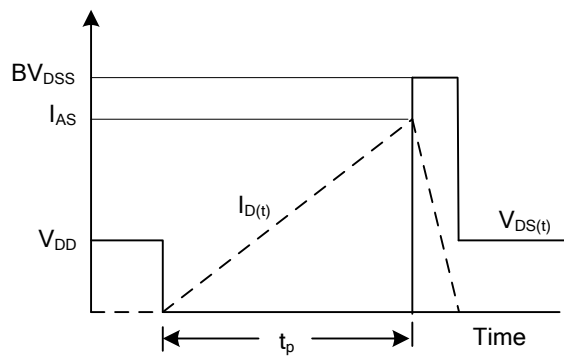
Gate Charge Test Circuit



Gate Charge Waveform

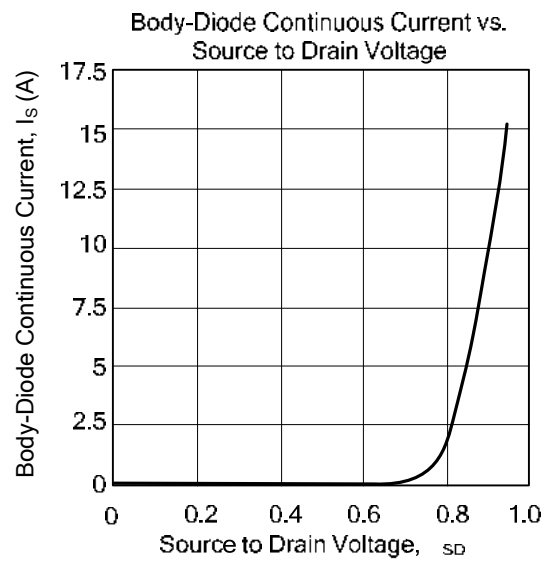
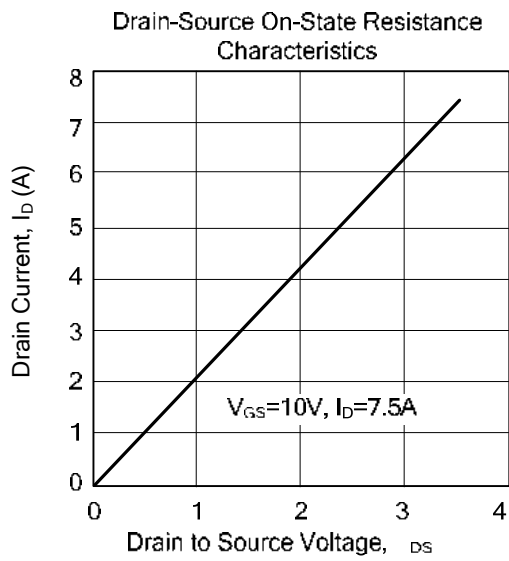
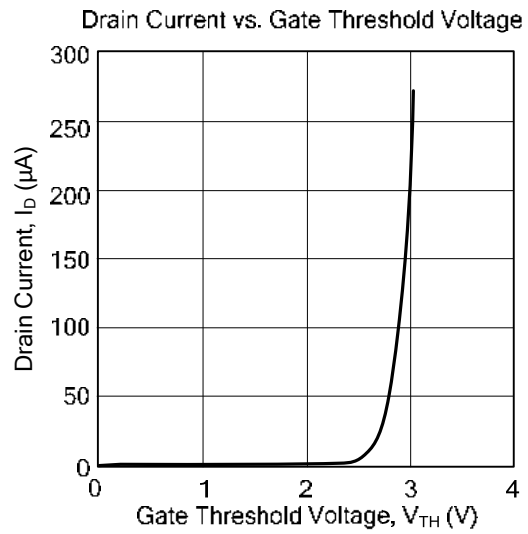
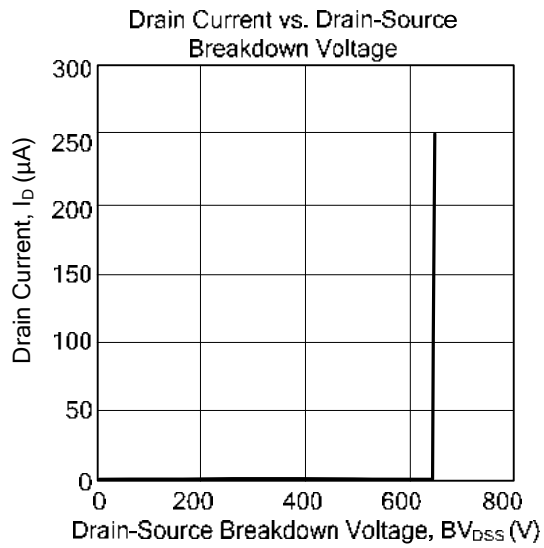


Unclamped Inductive Switching Test Circuit

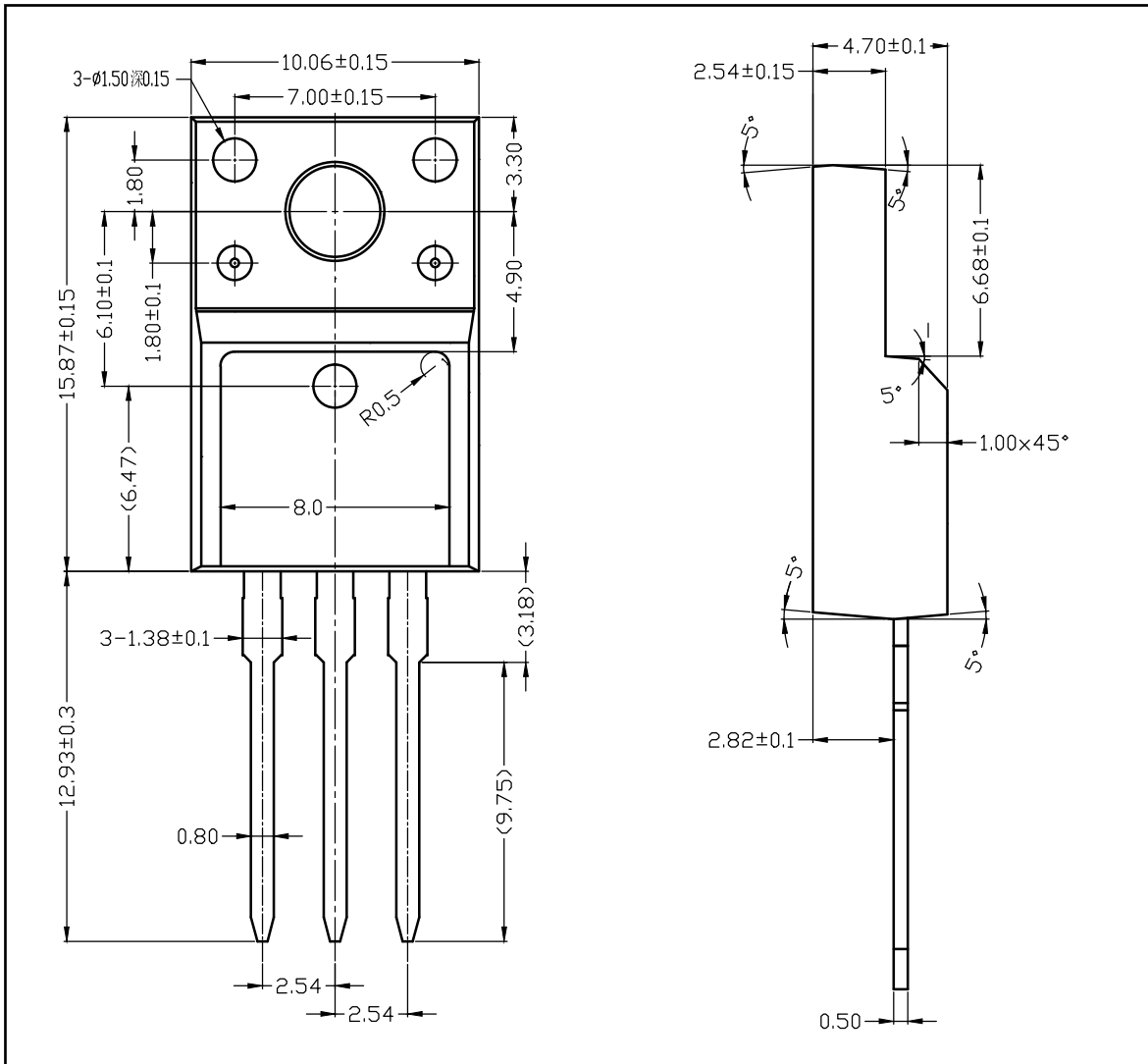


Unclamped Inductive Switching Waveforms

■ TYPICAL CHARACTERISTICS



■ TO-220F-3L PACKAGE OUTLINE DIMENSIONS



■ TO-220-3L PACKAGE OUTLINE DIMENSIONS

